FLIP CHIP MODULES TEST SPECS

TYPE: R303

INTERGRATING ONE-SHOT

TEST	CONDITIONS	MINIMUM	MAX I MUM
INPUT CURRENT	DCD GATE (PIN T)	1.5-2.0 MA	
	DIRECT (PIN V)	.75-1.0 _{MA}	
OUTPUT CURRENT	IOMA LOADS (PINS H,F)	9.0 _{MA}	11.0 MA
	ONE, ZERO OUTPUTS (PINS D,E)	1.5 MA	2.2 MA
LOWER LEVEL	IOMA LOADS (PINS H,F)	3.2 V	3.8 V
	ONE, ZERO OUTPUTS (PINS D,E)	3.2 _V	3.8 V
GATE THRESHOLD	FLIP-FLOP INPUT TO DCD PULSE INPUT; LEVEL INPUT THRESHOLD	1.5 y	2.5 y
DELAY	EXTERNAL 1 MFD (PIN J)	800-1600 μSEC	18-27 MSEC
	MINIMUM	≦3.5 µSEC	* μSEC
	PIN K	* μSEC	* μSEC
	PIN L	* μSEC	* MSEC
	PIN M	* MSEC	* MSEC
	PIN N	* MSEC	≥ 900 MSEC
JITTER	PIN M, IQ MSEC DELAY	/////	1.3 %
CHANGE WITH ± 20% VOLTAGE	PIN M, IO MSEC DELAY		1.9 %

* RANGES MUST OVERLAP.

TECHNICAL INFORMATION

12/19/66

Repair of printed circuitry should be done with a low voltage, fairly cool soldering iron to prevent damage to the transistors and keep the copper from lifting.

Oscilloscopes used to troubleshoot a module or system should be grounded to prevent damaging transients.